


<b>Search Notes</b>  	<b>Application/Control No.</b>  10689382	<b>Applicant(s)/Patent Under Reexamination</b>  BEAUMONT, MARK
	<b>Examiner</b>  Wai, Eric C	<b>Art Unit</b>  2195

SEARCHED			
Class	Subclass	Date	Examiner
718	100-101, 105	08/09/2007	ECW
712		08/09/2007	ECW
708	497	08/09/2007	ECW

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Primary Examiner Lewis Bullock	08/09/2007	ECW
East Search	08/09/2007	ECW
Google Search	08/09/2007	ECW
Inventor Name Search	08/09/2007	ECW
Consulted with Gail Hayes, Lewis Bullock, regarding 101 issues	02/22/2008	ECW
Updated East Search	02/22/2008	ECW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
718	100-101, 105	02/22/2008	ECW